

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
289272US2PCTSERIAL NO.
10/574,702

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Helene JOISTEN, et al.FILING DATE
April 5, 2006

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/JMP/	AA	2 743 416	04/24/56	KELLY, Joseph M. Jr.			
/JMP/	AB	6 060 181	5/9/2000	STOLK, Richard D.			
	AC						
	AD						
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	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/JMP/	AO	1 371 453	9/4/1964	FR		NO
↓	AP	942 468	2/9/1949	FR		NO
	AQ	1 597 324	9/3/1981	GB		NO
	AR					
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	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

/JMP/	AW	KAWAHITO, Shoji et al., "High-Resolution Micro-Fluxgate Sensing Elements Using Closely Coupled Coil Structures", Sensors and Actuators A, Vol. 54, No. 1-3, Pages 612-617, 1996.	
↓	AX	RUSTENBACH, J. et al., "Fluxgate Magnetometers for Balloons and Small Satellites", Elsevier Science, Vol. 35, Pages 89-98, 1995.	
↓	AY	GOTTFRIED-GOTTFRIED, R. et al., "A Miniaturized Magnetic-Field Sensor System Consisting of a Planar Fluxgate Sensors and a CMOS Readout Circuitry", Sensor and Actuators A, Vol. 54, Pages 443-447, 1996.	
↓	AZ	LASSAHN, Martin et al., "A Multi-Channel Magnetometer for Field Structure Measurement Based on Time Encoded Flux-Gate Sensors, IEEE Transactions on Instrumentation and Measurement, Vol. 42, No. 2, April 1993.	<input type="checkbox"/> Additional References sheet(s) attached

Examiner /Jay M. Patidar/

Date Considered 08/30/2007

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.